Applicant(s)/Patent Under Application/Control No. Reexamination 10/623,016 LEE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 DuyVu n. Deo 1765 **U.S. PATENT DOCUMENTS** Date **Document Number** Name Classification Country Code-Number-Kind Code MM-YYYY 216/67 Α US-5,626,775 05-1997 Roberts et al. US-В С US-US-D US-Ε F US-G US-Н US-US-US-J US-Κ US-L М US-FOREIGN PATENT DOCUMENTS Document Number Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S

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